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Arcitura Education Advanced Cloud Architecture Exam

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Questions
& Answers

Version: 5.0

Question: 1

The storage management portal is a portal that provides management features for

- A. Vertically tiered cloud storage devices
- B. Horizontally scaled cloud storage devices
- C. Block-based storage devices
- D. All types of cloud storage devices

Answer: D

Question: 2

Which pattern can be applied to establish a failover system for cloud storage devices that enables continuous data access for cloud consumers?

- A. Direct LUN Access
- B. Redundant Storage
- C. Storage Workload Management
- D. Intra-Storage Device Vertical Tiering

Answer: B

Question: 3

The application of the Intra-Storage Device Vertical Tiering pattern establishes a system that optimizes the availability of different disk types of the same capacity.

- A. True
- B. False

Answer: B

Question: 4

Applying the Dynamic Failure Detection and Recovery pattern establishes a _____ that can monitor and respond to runtime failure conditions.

- A. Watchdog system
- B. Capacity planner system
- C. Failover system
- D. Intelligent automation engine

Answer: A

Question: 5

After applying the _____ pattern, a system is established in which a _____ is used to provide virtual servers with direct access to LUNs.

- A. Direct LUN Access, hypervisor
- B. Redundant Storage, cloud storage device
- C. Direct LUN Access, physical host bus adapter card
- D. Redundant Storage, virtual switch

Answer: C

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